X-ray Optics

X-Ray Astronomy School III

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How do we form an X-Ray Image?

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 - Use morphology to apply intuition and choose models.

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- 4. To serve with high spectral resolution dispersive spectrometers such as transmission or reflection gratings.
- 5. To simultaneously measure both the sources of interest, and the contaminating background using other regions of the detector.

X-Ray Optics

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 - Fresnel's Equations

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 - Total External Reflection
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- 2. We must make the X-rays form an Image
 - Mirror Figure
 - Scattering

X-Ray Reflection: Zero Order Principles:

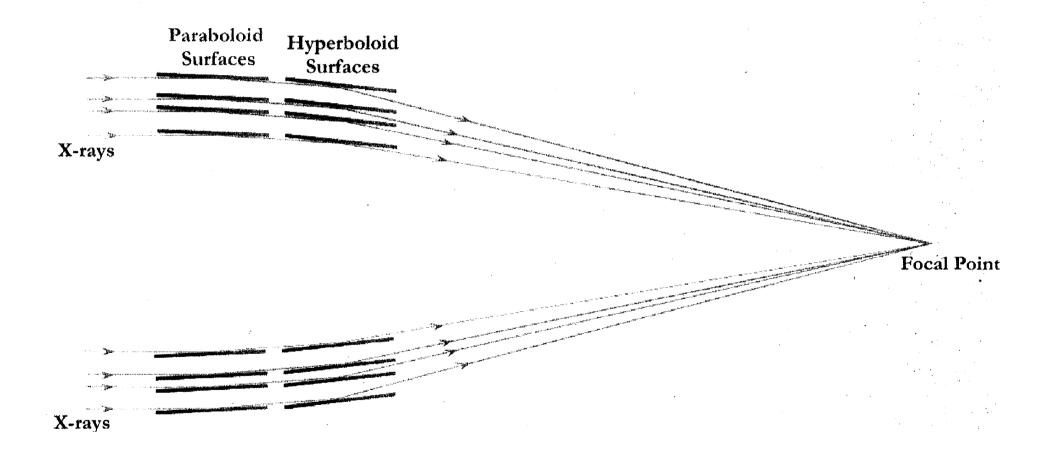
Refs:

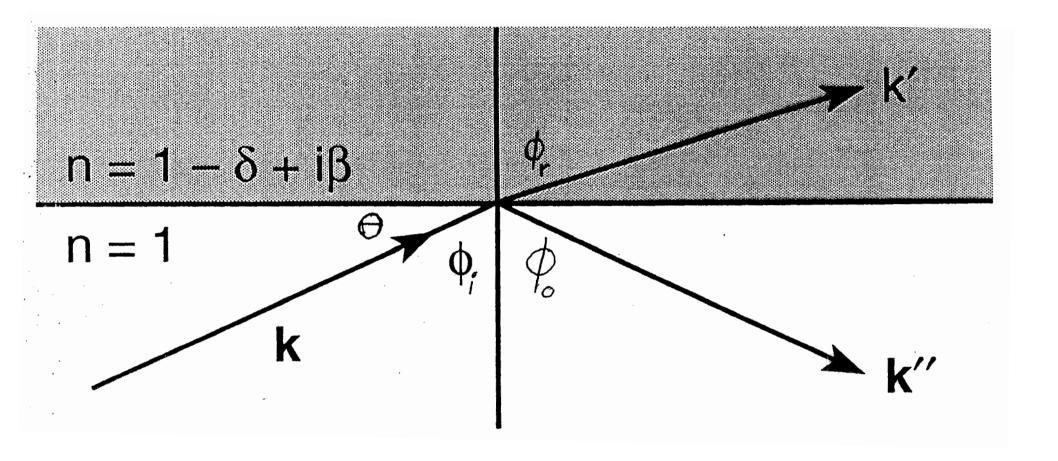
Gursky, H., and Schwartz, D. 1974, in "X-Ray Astronomy," R. Giacconi and H. Gursky eds., (Boston: D. Reidel) Chapter 2, pp 71-81;

Aschenbach, B. 1985, Rep. Prog. Phys. 48, 579.

X-rays undergo total external reflection at small grazing angles. An analogy is skipping stones on water.

Scattering of any wave by an ensemble of electrons is coherent only in very special directions; namely, the familiar *Angle of Incidence equals Angle of Reflection*, $\phi_i = \phi_o$.





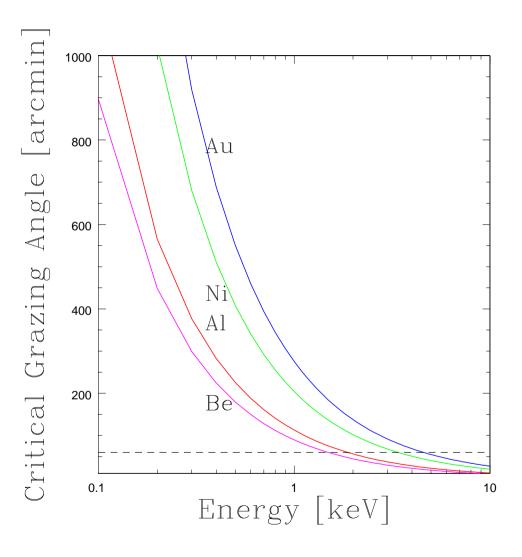
We have Snell's law for refraction, $\sin \phi_r = \sin \phi_i / n$ or $\cos \theta_r = \cos \theta_i / n$ ϕ is the standard angle of incidence from the surface normal, θ is the grazing angle from the surface.

The complex index of refraction is $n = 1-\delta + i\beta$.

We have used the subscripts i for the incident photon, o for the reflected or outgoing photon, and r for the refracted photon.

Figure from Atwood, D. 1999, "Soft X-rays and Extreme Ultraviolet Radiation: Principles and Applications, (http://www.coe.berkeley.edu/AST/sxreuv)

Critical Grazing Angle



To 1st order, total external reflection works for $\theta_i \leq \theta_c$ where $1 = \cos \theta_r = \cos \theta_c/n$. At the limiting condition $\cos \theta_c = n$, Since θ is small (and forgetting β

for the moment)

1-
$$\theta_c^2/2 = 1$$
- δ , therefore $\theta_c = \sqrt{(2\delta)}$.

Away from absorption edges, $\delta = r_0 \lambda^2 N_e / (2\pi)$

- 1. The critical angle decreases inversely proportional to the energy
- 2. Higher Z materials reflect up to higher energies, at a fixed grazing angle.

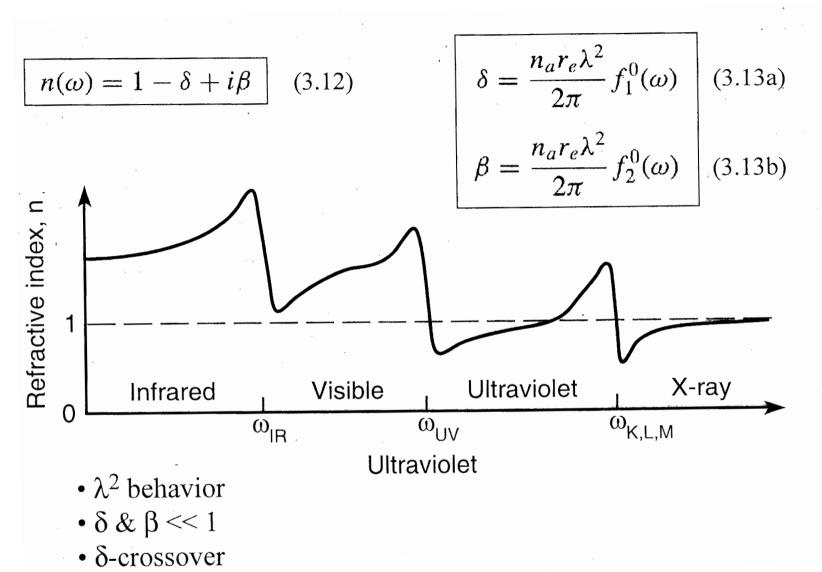
SPECIAL TOPIC: Index of Refraction

Attwood, D. 1999, "Soft X-rays and Extreme Ultraviolet Radiation: Principles and Applications, (http://www.coe.berkeley.edu/AST/sxreuv)

If we consider a plane wave, $E(r,t)=E_0 e^{-i(\omega t-k\cdot r)}$, the dispersion relation $\omega/k=c$ in vacuum, and $\omega/k=c/n$ in a medium with index of refraction n. Substituting $k=(\omega/c)$ n in the reflecting medium, then in the direction of propagation we have

$$\mathbf{E}(\mathbf{r},\mathbf{t}) = \mathbf{E}_0 \ \mathbf{e}^{-i[\omega t - (\omega/\mathbf{c})(1 - \delta + i\beta)\mathbf{r}]} = \mathbf{E}_0 \ \mathbf{e}^{-i\omega(\mathbf{t} - \mathbf{r}/\mathbf{c})} \ \mathbf{e}^{-i(\omega\delta/\mathbf{c})\mathbf{r}} \ \mathbf{e}^{-(\omega\beta/\mathbf{c})\mathbf{r}}.$$

The roles are now clear: we have the wave which would propagate in vacuum, a phase shift caused by the small real deviation from unity, and an attenuation caused by the imaginary part of the index of refraction.



The complex atomic scattering factor $f=(f_1-i\ f_2)$ is a sum over all the electrons, weighted inversely by the difference of the squares of the frequency of the photon and the resonant frequency of the electron and considering a damping factor. It can be calculated from a macroscopic observable: the atomic photon absorption cross section μ_a :

$$f_2(E) = (E \mu_a(E))/(2\pi r_0 hc)$$
, and $f_1 = Z + 1/(\pi r_0 hc) \int_0^\infty (x^2 \mu_a(E))/(E^2 - x^2) dx + \Delta f_{rel}$

X-Ray Reflection: Fresnel Equations

The Fresnel equations give the correct amplitudes of reflection (and refraction) for a plane wave incident on an infinitely smooth surface. Use Maxwell's equations, keeping the components of E_{\parallel} and H_{\parallel} and D_{\perp} and B_{\perp} continuous across the interface.

We need to consider polarization to apply the boundary conditions. The reflected wave will have the amplitude

r_p for the parallel component

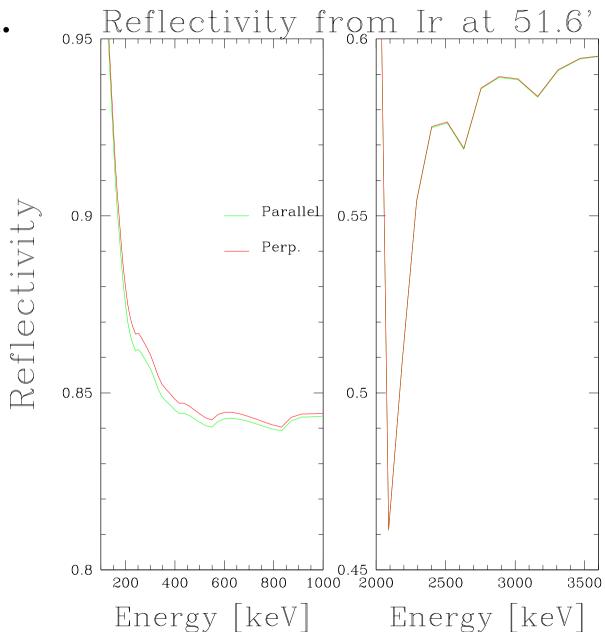
 r_s for the perpendicular component of the electric vector.

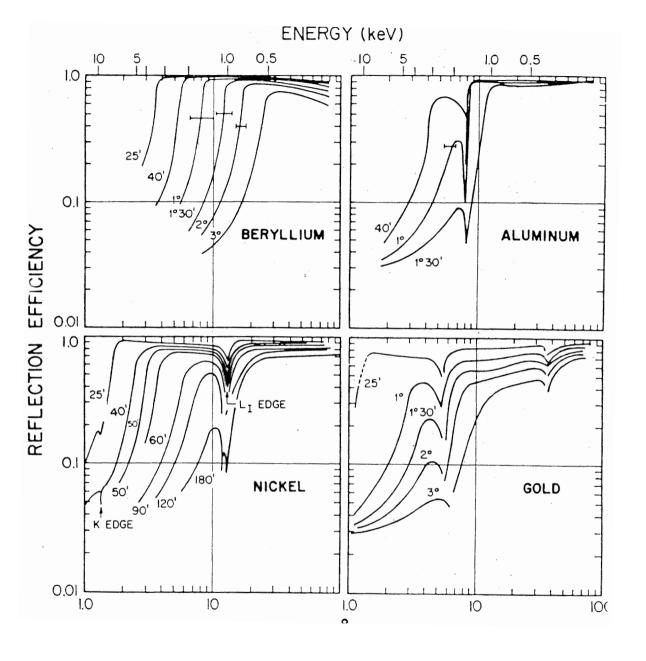
The squared amplitudes of the complex numbers \mathbf{r}_p and \mathbf{r}_s are the actual reflectivities.

For unpolarized X-rays the reflectivity is just $(|\mathbf{r}_p|^2 + |\mathbf{r}_s|^2)/2$

 $r_{p} = (n^{2} \sin \theta - (n^{2} - \cos^{2} \theta)^{1/2}) / (n^{2} \sin \theta + (n^{2} - \cos^{2} \theta)^{1/2})$ $r_{s} = (\sin \theta - (n^{2} - \cos^{2} \theta)^{1/2}) / (\sin \theta + (n^{2} - \cos^{2} \theta)^{1/2})$

and $r_p \simeq r_s$ for X-rays, since $n \simeq 1$.





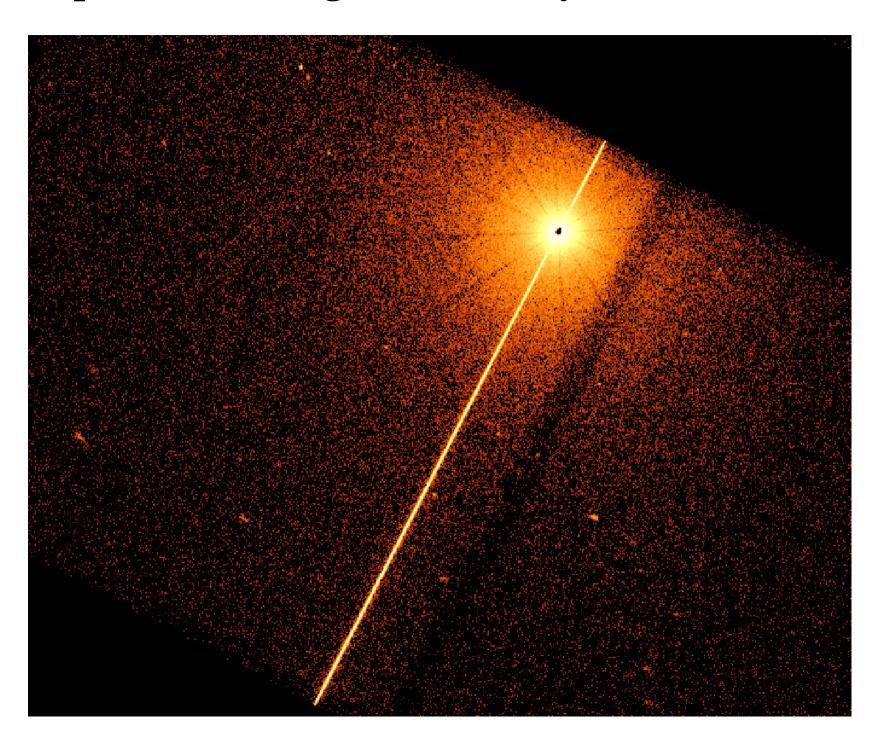
Two Significant effects remain:

1. The surfaces are not infinitely smooth. This gives rise to the complex subject of X-ray scattering. Scattering cannot be treated *exactly*, one must consider a statistical description of the surface roughness.

Key Features:

Scattering increases as ${\bf E}^2$ In plane scattering dominates by factor $1/\sin\theta$

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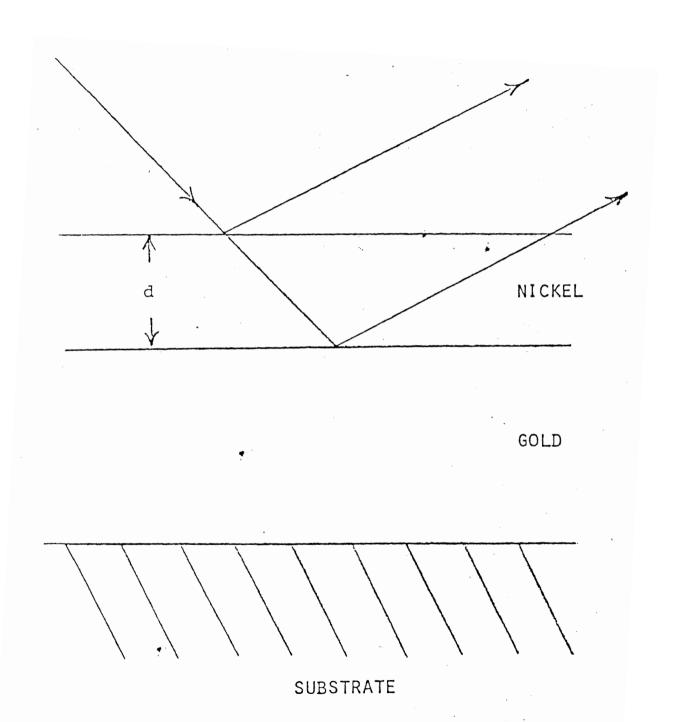
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Feature: Interference can cause oscillations in reflectivity.

Interference from multilayers can modify the reflectivity.



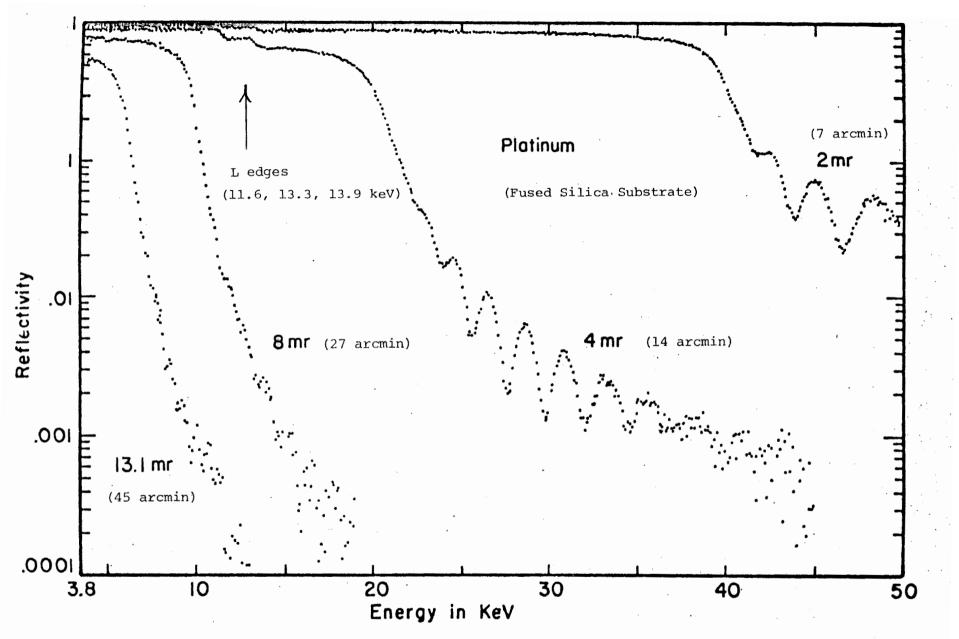
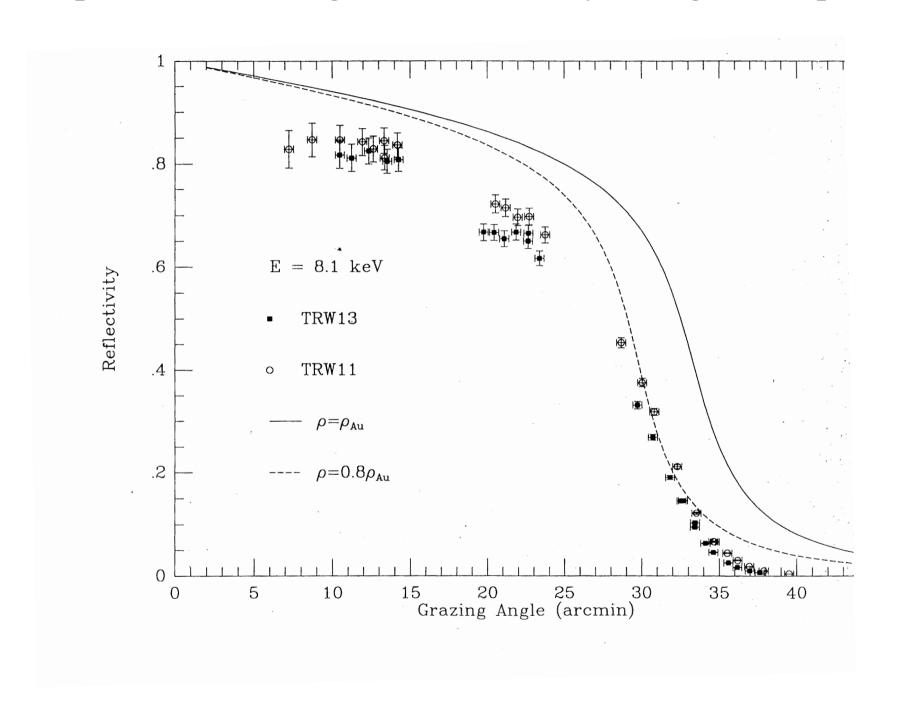


Figure 3.2 The reflectivity of a platinum coated mirror as a function of energy and grazing angle.

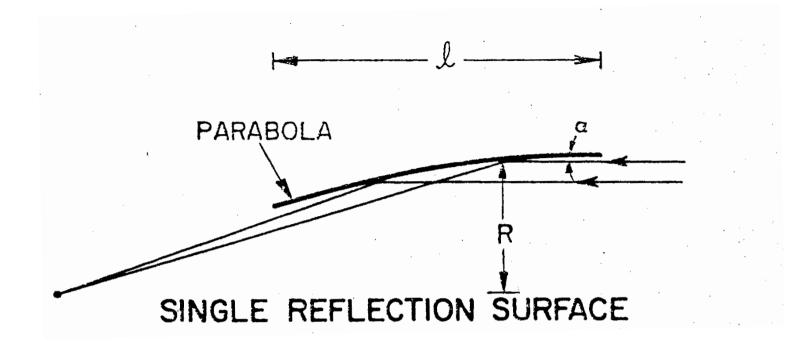
Preparation of coating affects reflectivity through the dependence on density.



X-Ray Mirrors: Parabola

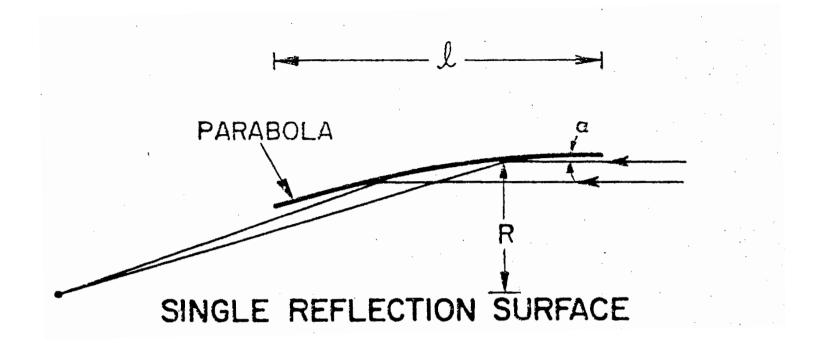
A parabola focusses rays incident parallel to its axis to a point.

Off-axis, the blur circle increases linearly with the off-axis angle.



An incoming ray will hit the parabola at an angle $\alpha = \arctan(\frac{dR}{dz})$ and be diverted through an angle 2α . One verifies that $R^2=4$ fz satisfies the differential equation $\tan 2\alpha = R/(z-f)$, where f is the distance from the origin to the focus, and can be set, e.g., by choosing that the mirror segment, of length ℓ , have a specific grazing angle α at a radius R.

Focal Length: $F=R/2\alpha$



There are two uses for the parabola:

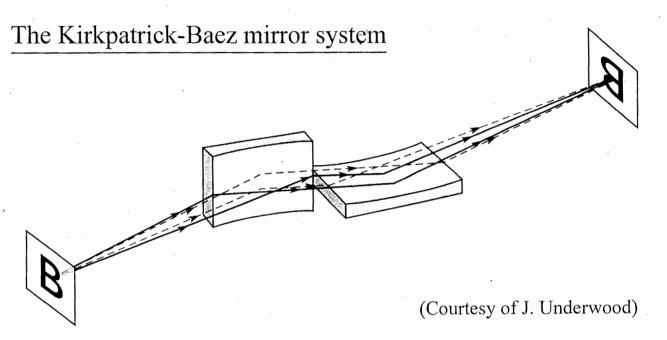
1. Translate the parabola to form a plate, curved in one dimension. This will produce one dimensional focussing of a point to a line, while another plate at right angles can focus in the other dimension.

Parabolic Plate Area = $\alpha \ell$ h

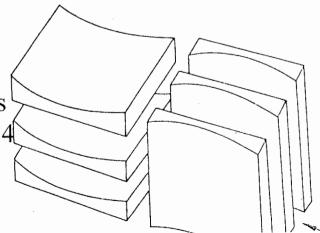
2. Form a Paraboloid of revolution, and use with an hyperboloid. Paraboloid Area= $2\pi R \alpha \ell$



Focusing with Curved, Glancing Incidence Optics



- Two crossed cylinders (or spheres)
- Astigmatism cancels
- Fusion diagnostics
- Common use in synchrotron radiation beamlines
- See hard x-ray microprobe, chapter 4, figure 4.14



X-Ray Mirrors: Wolter's Configurations

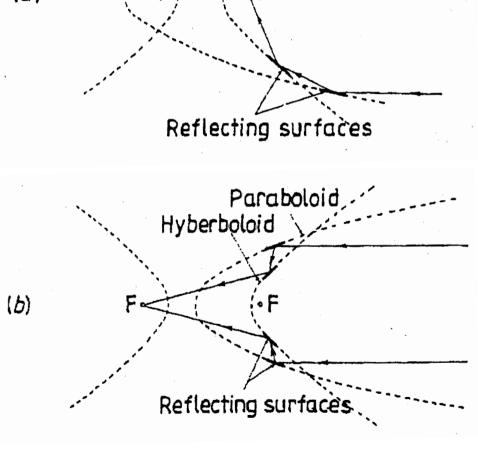
Wolter, H. 1952, Ann. Physik 10, 94; ibid. 286; Giacconi, R. & Rossi, B. 1960, J. Geophys. Res. 65, 773

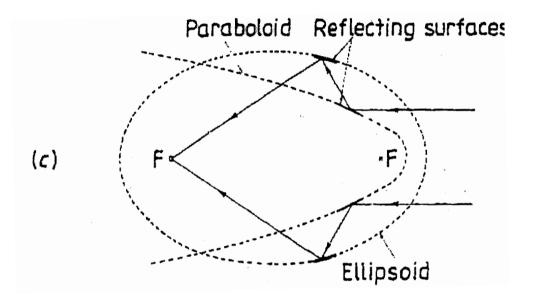
A Paraboloid produces a perfect focus for on-axis rays. However, off-axis it gives a coma blur of equivalent image size proportional to the distance off-axis. Wolter's classic paper proved two reflections were needed, and considered configurations of conics to eliminate coma. Basic Principle: The optical path to the image must be identical for all rays incident on the telescope, in order to achieve perfect imaging.

Wolter derived three possible Geometries.

The Wolter Geometries

B Aschenbach Confocal hyperboloid Paraboloid. (a) Reflecting surfaces

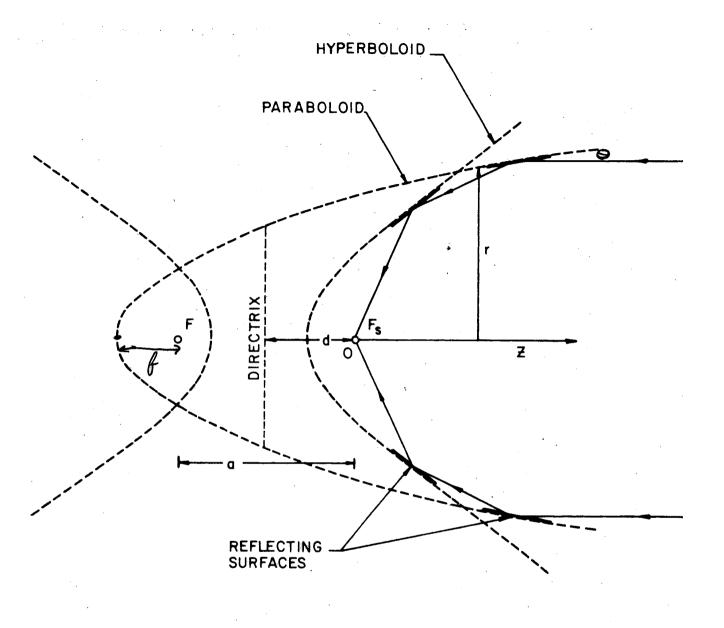




X-Ray Mirrors: Wolter's Configurations

The Paraboloid-Hyperboloid is overwhelming most useful in cosmic X-ray astronomy:

- Shortest Focal length to aperture ratio. This has been a key discriminant as we are always trying to maximize the collecting area to detect weak fluxes, but with relatively severe restrictions on length (and diameter) imposed by available space vehicles.
- For resolved sources, the shorter focal length concentrates a given spatial element of surface brightness onto a smaller detector area, hence gives a better signal to noise ratio against the non-X-ray detector background.

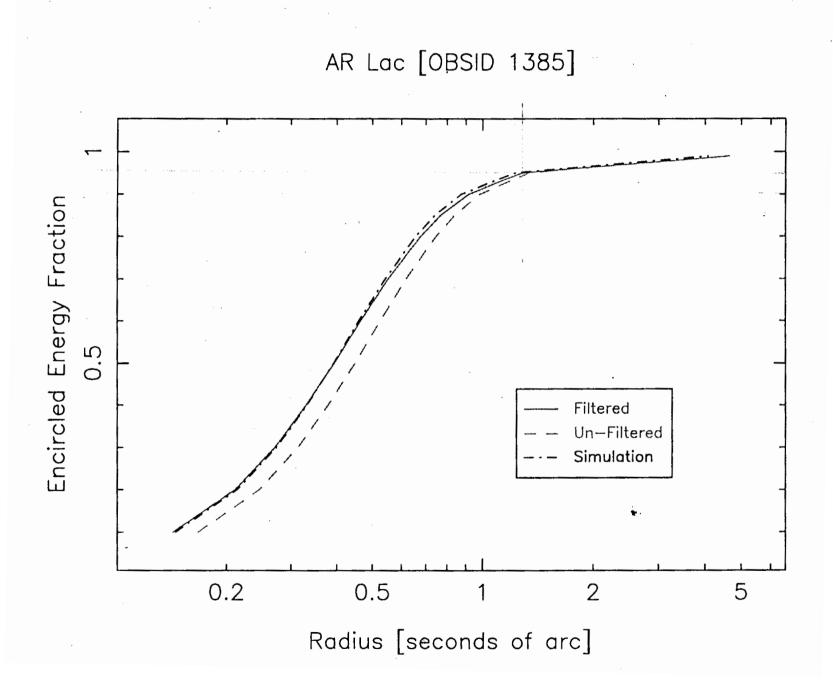


THE PRINCIPLE OF THE WOLTER TYPE I TELESCOPE. THE TELESCOPE FOCUS IS AT Fs. THE FOCUS OF THE PARABOLOID IS AT THE SECOND FOCUS OF THE HYPERBOLOID.

X-Ray Mirrors: Paraboloid-Hyperboloid

Structural advantage of the intersecting P and H surfaces. Includes mounting, nesting, and vignetting considerations. For replicated mirrors, the P and H figures are typically polished on a single mandrel and the pair formed as a single piece.

One requirement of the shorter focal length is that it puts more demand on having a detector with smaller spatial resolution in order to sample the image. Encircled energy results, relative to flux in a 10" radius aperture:



X-ray Focus

A Grazing Incidence telescope acts as a thin lens. As the telescope tilts about small angles, the image of a point source near the axis remains invariant in space.

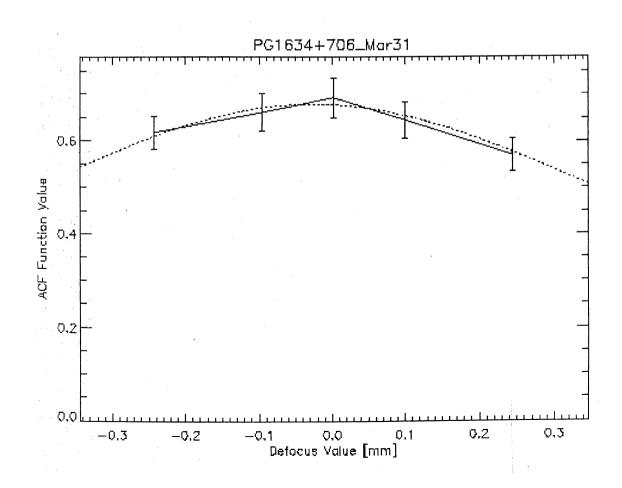
- This is what allows us to convert a linear distance y between two images to an angular distance $\theta = y/F$.
- This shows that the optimum focal surface is a bowl shape, sitting on the flat plane perpendicular to the optical axis.

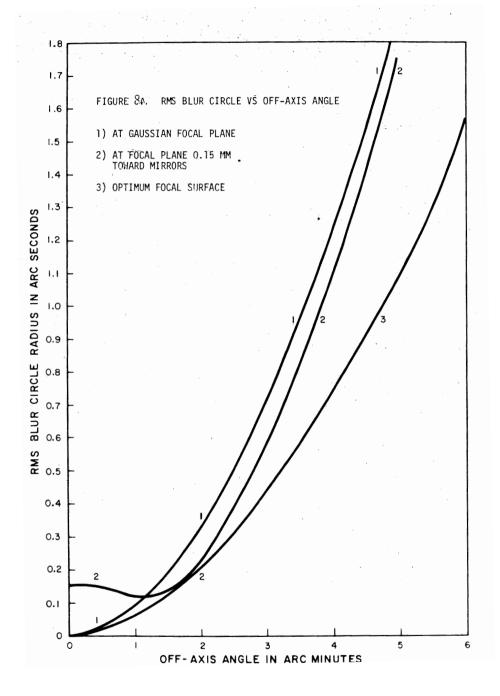
In a Wolter I system the rays from an on-axis point source converge to focus in a cone of half-angle four times the grazing angle.

X-ray Focus

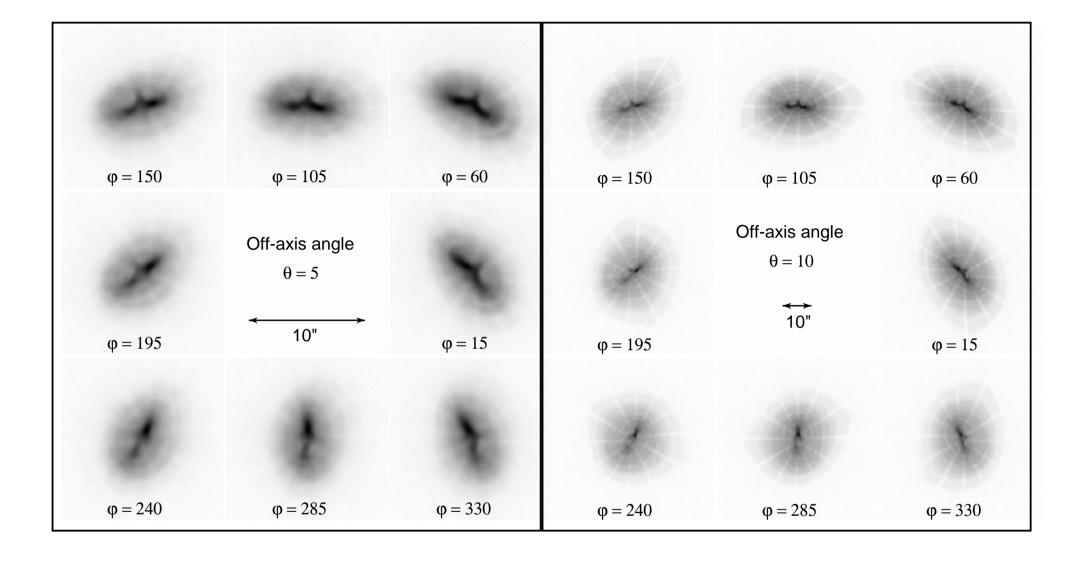
Chandra cone angles are 3.417°, 2.751°, 2.429°, and 1.805°. For a 0.1" contribution to the on-axis blur due to imprecision of the focus, we must be able to focus within

 $5 \mu \text{m/tan} 3.4^{\circ} = 85 \mu \text{m}.$





Because the optimal focal plane is curved toward the mirror, and because optical imperfections in mirror figure and mechanical tolerances in aligning the pieces of glass prevent perfect imaging on axis, it is generally advantageous to position a flat imaging detector slightly forward of the ideal on-axis focus.



Chandra point spread function, 5 and 10 arc minutes off-axis. Notice asymmetric effects, due to alignment. Raytrace calculation.

SPECIAL TOPIC: Multilayer Reflection

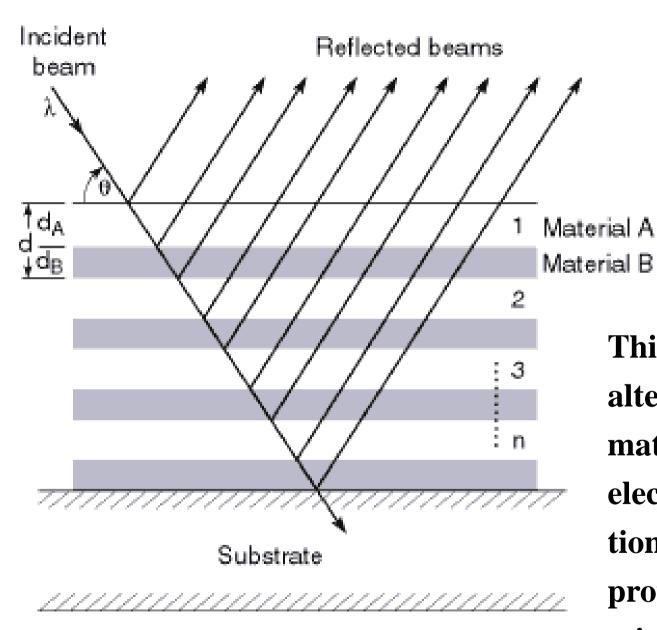
Underwood, J.2001, X-ray data booklet, sect. 4.1 (http://xdb.lbl.gov)

Near normal incidence reflection of soft X-rays is $\approx 10^{-4}$.

This is because the X-rays penetrate the material until they are absorbed.

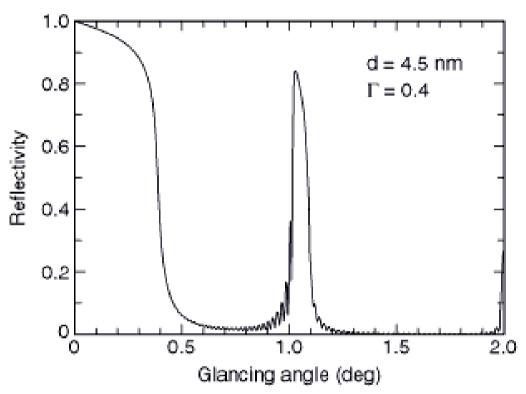
 10^{-4} reflectivity means a reflected amplitude of 10^{-2} , so if we can get ~ 100 layers to add coherently we can achieve significant reflection probability.

Multi-Layer Reflection



This has been realized with alternate layers of high Z material, to provide a high electron density for reflection, and low Z material, to provide a phase shift with minimal absorption.

Multi-Layer Reflection



A bonus *and* disadvantage is that the resulting mirror typically only has an energy bandpass of 1% to 10%. Golub and colleagues have used normal incidence mirrors with great success to image selected pass bands for the sun.

Multilayers currently are being studied intensively for application at grazing incidence angles in the 10's of keV range.

Scattering

Features:

1. Scattering is predominantly in the plane of the incident X-ray and the normal to the surface. Out of plane scattering is less by a factor $\sin \alpha$.

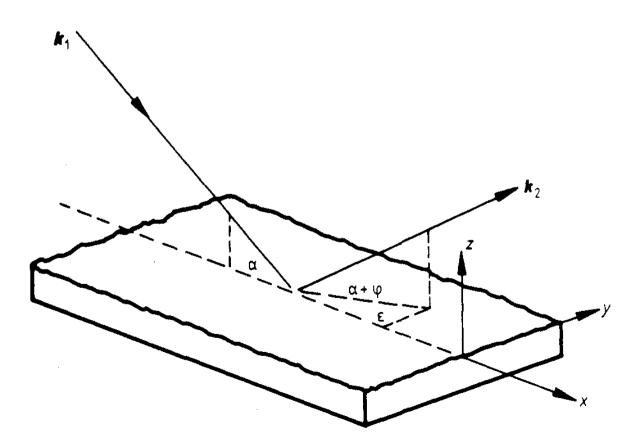
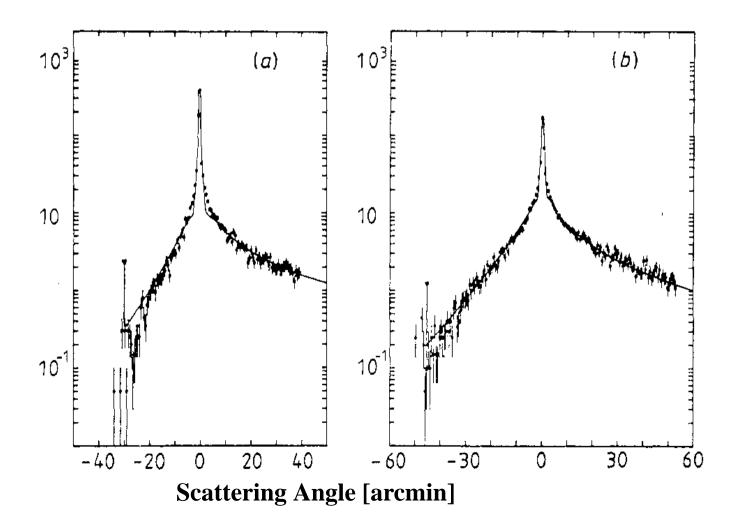


Figure 1. Scattering geometry. k_1 and k_2 denote the wavevector of the incident and scattered ray, respectively.

Scattering

Features:

2. Scattering is asymmetric. Backward scattering can be no more than $-\alpha$, which would take the ray into the surface. Forward scattering is unlimited.



Scattering

Aschenbach, B. 1985, Rep. Prog. Phys. 48, 579; Zhao, P. & VanSpeybroeck, L. P. 2002, SPIE 4844.

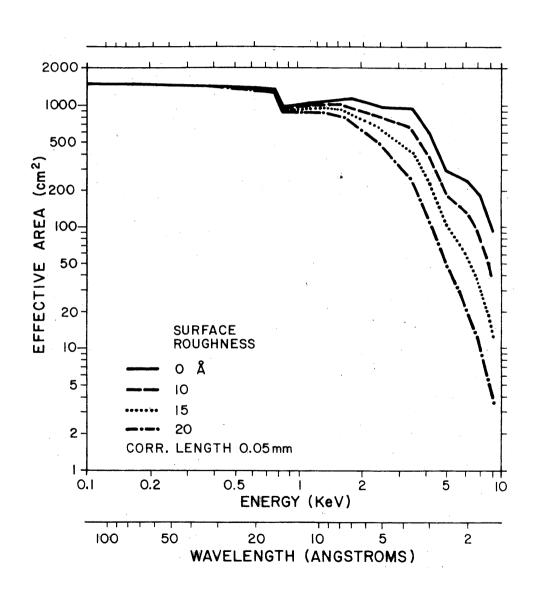
Scattering theory treats irregularities in the surface height h as random, characterized by a power spectral density function

$$2W_1(f) = |\int e^{i2\pi x f} h(x) dx|^2$$

For sufficiently smooth surfaces scattering can be considered as diffraction, so that light of wavelength λ is scattered due to irregularities with spatial frequency f according to the usual grating equation: $f = \epsilon \sin \alpha / \lambda$, where α is the grazing angle and ϵ the scattering angle.

The scattered intensity, relative to the total power in the focal plane, is $\psi(\epsilon)=2W_1(f) \, 8\pi (\sin \alpha)^4/f \, \lambda^4$

Scattering is Proportional to E^2



For a Gaussian distribution of surface heights, and no correlation of roughness with direction, the relative total scattered intensity is $1-e^{-(4\pi\sigma\sin\alpha/\lambda)^2}\sim (4\pi\sigma\sin\alpha/\lambda)^2$ when the exponent is small. The rms roughness of the surface, σ is defined as $\sigma^2=\int 2W_1(f)\,df$.